

BROAD AREA LASER

GaAs Semiconductor Laser Diode Single Emitter Structure







21.07.2017



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General Product Information

Product	Application
670 nm Broad Area Laser	Sensing
for Pulse Mode Operation	
sealed TO Housing	



Absolute Maximum Ratings

	Symbol	Unit	min	typ	max
Storage Temperature	Ts	°C	-40		85
Operational Temperature at Case	T _C	°C	-35		80
Peak Current	I _{F Peak}	Α			3.0
Reverse Voltage	V_R	V			2
Peak Output Power	P _{opt Peak}	W			2.4
Forward Voltage at Peak	V_{F}	V			2.7

Every condition of the Absolute Maximum Ratings has to be kept during operation
see Pulse Mode Conditions, @ 25° C
see Pulse Mode Conditions
see Pulse Mode Conditions

Recommended Operational Conditions (Pulse Mode)

	Symbol	Unit	min	typ	max
Operational Temperature at Case	T _C	°C	15		40
Forward Current	I _{F Peak}	Α			2.4
Output Power	P _{opt Peak}	W		1.8	

Measurement Conditions / Comments		
see Pulse Mode Conditions, @ 25° C		
see Pulse Mode Conditions		

Characteristics at T_{amb} 25 °C, Pulse Mode, Begin Of Life

Parameter	Symbol	Unit	min	typ	max
Center Wavelength	λ_{C}	nm	660	670	680
Spectral Width (FWHM)	$\Delta\lambda$	nm		4	6
Temperature Coefficient of Wavelength	dλ / dT	nm / K		0.18	
Peak Output Power @ $I_F = 2.4 A$	Popt Peak	W		1.8	
Threshold Current	I _{th}	А		0.5	
Differential Series Resistance	R_{S}	Ω		0.1	
Slope Efficiency	η	W/A		1.0	

Measurement Conditions / Comments
see Pulse Mode Conditions
see Pulse Mode Conditions
see ruise Mode Conditions

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Characteristics at T_{amb} 25 °C, Pulse Mode, Begin Of Life

Parameter	Symbol	Unit	min	typ	max
Cavity Length	L	μm		1500	
Stripe width	Ws	μm		100	
Divergence parallel (FWHM)	$\Theta_{ }$	0		10	
Divergence perpendicular (FWHM)	Θ_{\perp}	0		30	
Polarization				TE	
Spectral Mode (longitudinal)				Multi Mode	

Measurement Conditions / Comments
E field parallel to Pin 2 - Pin 3 - plane

Pulse Mode Conditions

Parameter	Symbol	Unit	min	typ	max
Pulse Length	t _p	μs		10	
Pulse Repetition Rate	RR_p	s ⁻¹		5000	

Measurement Conditions / Comments

Ordering Information:



800 Village Walk #316 Guilford, CT 06437 Ph: 203-401-8093

Email orders to: sales@xsoptix.com
Fax orders to: 800-878-7282



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Revision 0.70





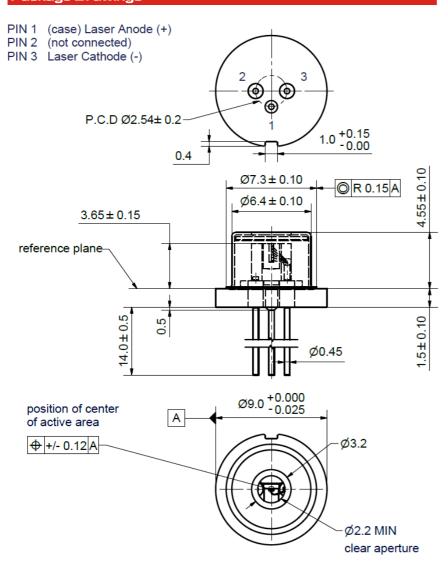
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Package Dimensions

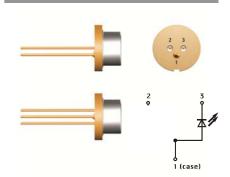
Parameter	Symbol	Unit	min	typ	max
Height of Emission Plane	d _{EP}	mm		3.65	
Excentricity of Emission Center	R	mm			0.12
Pin Length	I	mm		14.0	

Measurement Conditions / Comments reference plane A: top side of TO header reference B: center of outer diameter of header

Package Drawings



Pinout



Finish of the pins: Ni-EP1 \sim 8 μ m + Au-P 0.8 μ m min

Z14-0000-S0T23-BAL-0001



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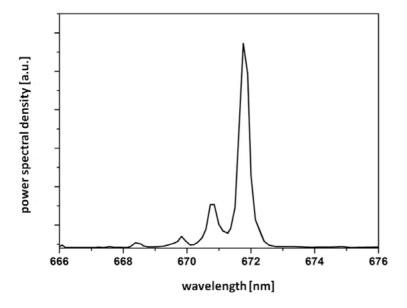






Typical Measurement Results

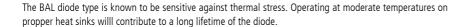
Spectrum



Performance figures, data and any illustrative material provided in this specification are typical and must be specifically confirmed in writing by eagleyard Photonics before they become applicable to any particular order or contract. In accordance with the eagleyard Photonics policy of continuous improvement specifications may change without notice.

Unpacking, Installation and Laser Safety

Unpacking the laser diodes should only be done at electrostatic safe workstations (EPA). Though protection against electro static discharge (ESD) is implemented in the laser package, charges may occur at surfaces. Please store this product in its original package at a dry, clean place until final use. During device installation, ESD protection has to be maintained.



The laser emission from this diode is close to the invisible infrared region of the electromagnetic spectrum. Avoid direct and/or indirect exposure to the free running beam. Collimating the free running beam with optics as common in optical instruments will increase threat to the human eye.

Each laser diode will come with an individual test protocol verifying the parameters given in this document.









IEC 60825-1



